

# MOSFET – N-Channel, UniFET™

200 V, 16 A, 125 mΩ

## FDD18N20LZ

### Description

UniFET MOSFET is ON Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.

### Features

- $R_{DS(on)} = 125 \text{ m}\Omega$  (Typ.) @  $V_{GS} = 10 \text{ V}$ ,  $I_D = 8 \text{ A}$
- Low Gate Charge (Typ. 30 nC)
- Low  $C_{RSS}$  (Typ. 25 pF)
- 100% Avalanche Tested
- Improved dv/dt Capability
- ESD Improved Capability
- This Device is Pb-Free and is RoHS Compliant

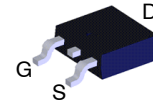
### Applications

- LED TV
- Consumer Appliances
- Uninterruptible Power Supply



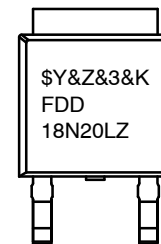
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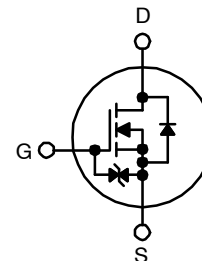


DPAK3 (TO-252 3 LD)  
CASE 369AS

### MARKING DIAGRAM



FDD18N20LZ = Specific Device Code  
\$Y = ON Semiconductor Logo  
&Z = Assembly Plant Code  
&3 = 3-Digit Date Code  
&K = 2-Digits Lot run Traceability Code



N-Channel MOSFET

### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

# FDD18N20LZ

## MOSFET MAXIMUM RATINGS ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	FDD18N20LZ	Unit
$V_{DSS}$	Drain to Source Voltage	200	V
$V_{GSS}$	Gate to Source Voltage	$\pm 20$	V
$I_D$	Drain Current	Continuous ( $T_C = 25^\circ\text{C}$ )	16
		Continuous ( $T_C = 100^\circ\text{C}$ )	9.6
$I_{DM}$	Drain Current (Note 1)	Pulsed	64
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	320	mJ
$I_{AR}$	Avalanche Current (Note 1)	16	A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	8.9	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	10	V/ns
$P_D$	Power Dissipation	( $T_C = 25^\circ\text{C}$ )	89
		Derate above $25^\circ\text{C}$	0.7
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	300	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive rating: pulse-width limited by maximum junction temperature.
2.  $L = 2.5\text{ mH}$ ,  $I_{AS} = 16\text{ A}$ ,  $V_{DD} = 50\text{ V}$ ,  $R_G = 25\ \Omega$ , starting  $T_J = 25^\circ\text{C}$ .
3.  $I_{SD} \leq 16\text{ A}$ ,  $di/dt \leq 200\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , starting  $T_J = 25^\circ\text{C}$ .

## THERMAL CHARACTERISTICS

Symbol	Parameter	FDD18N20LZ	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	1.4	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	83	

# FDD18N20LZ

## ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS

BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 25°C	200	–	–	V
ΔBV <sub>DSS</sub> / Δ	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C	–	0.2	–	V/°C
T <sub>J</sub> I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V	–	–	1	μA
		V <sub>DS</sub> = 160 V, T <sub>C</sub> = 125°C	–	–	10	
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	–	–	±10	μA

### ON CHARACTERISTICS

V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	1.0	–	2.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8 A	–	0.10	0.125	Ω
		V <sub>GS</sub> = 5 V, I <sub>D</sub> = 8 A	–	0.11	0.13	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 2 A	–	11	–	S

### DYNAMIC CHARACTERISTICS

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V f = 1 MHz	–	1185	1575	pF
C <sub>oss</sub>	Output Capacitance		–	190	255	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		–	25	40	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V	V <sub>DS</sub> = 200 V, I <sub>D</sub> = 16 A, V <sub>GS</sub> = 10 V (Note 4)	–	30	40	nC
Q <sub>gs</sub>	Gate to Source Gate Charge		–	3.5	–	nC
Q <sub>gd</sub>	Gate to Drain “Miller” Charge		–	8.5	–	nC

### SWITCHING CHARACTERISTICS

t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 100 V, I <sub>D</sub> = 16 A, V <sub>GS</sub> = 10 V, R <sub>G</sub> = 25 Ω (Note 4)	–	15	40	ns
t <sub>r</sub>	Turn-On Rise Time		–	20	50	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		–	135	280	ns
t <sub>f</sub>	Turn-Off Fall Time		–	50	110	ns

### DAIN-SOURCE DIODE CHARACTERISTICS

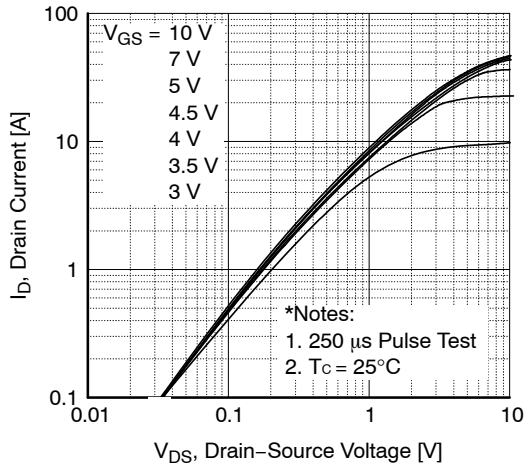
I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current		–	–	16	A
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		–	–	64	A
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 4 A	–	–	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 4 A dI <sub>F</sub> /dt = 100 A/μs	–	105	–	ns
Q <sub>rr</sub>	Reverse Recovery Charge		–	0.4	–	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

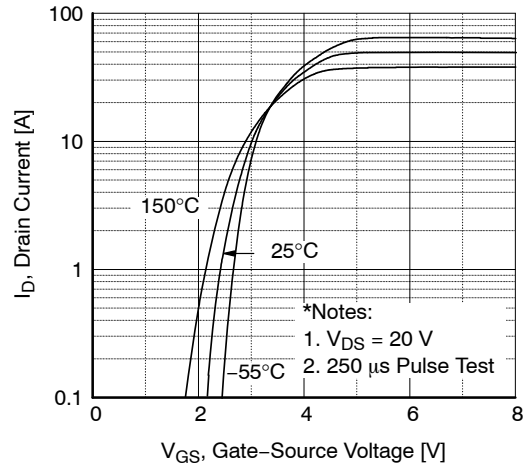
4. Essentially independent of operating temperature typical characteristics.

# FDD18N20LZ

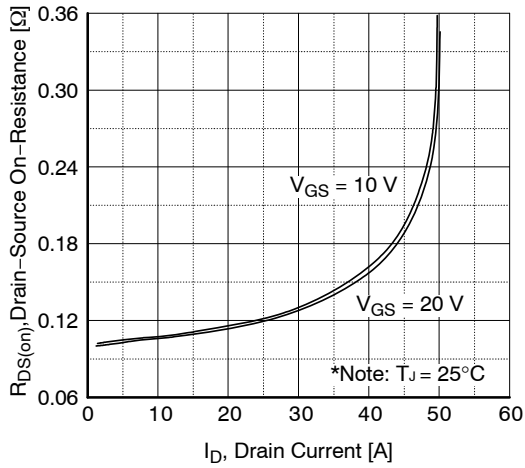
## TYPICAL PERFORMANCE CHARACTERISTICS



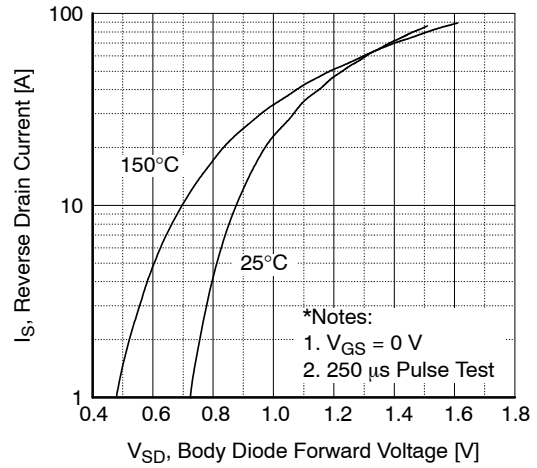
**Figure 1. On-Region Characteristics**



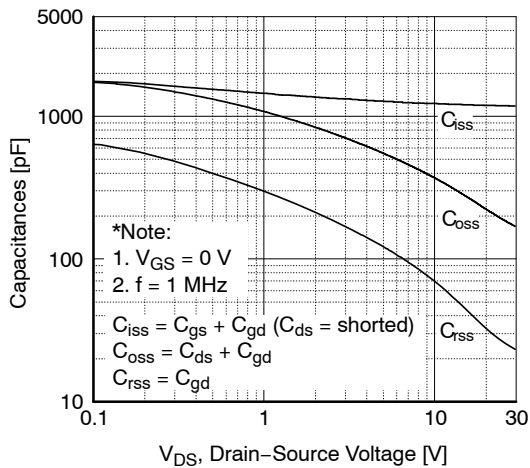
**Figure 2. Transfer Characteristics**



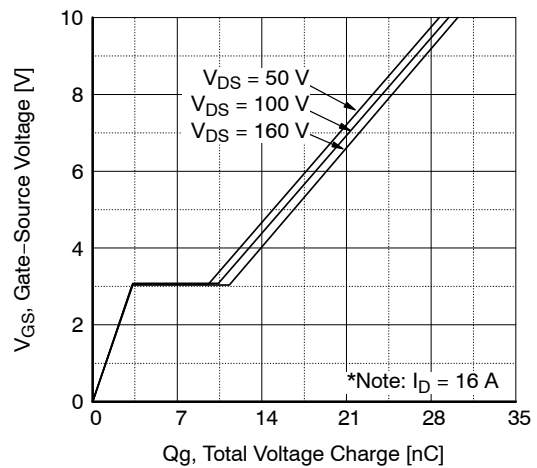
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**



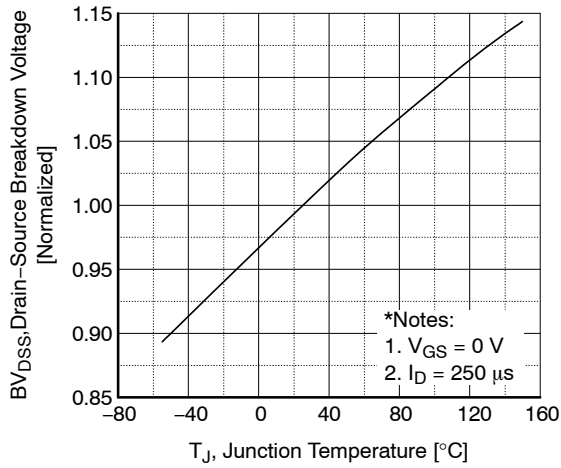
**Figure 5. Capacitance Characteristics**



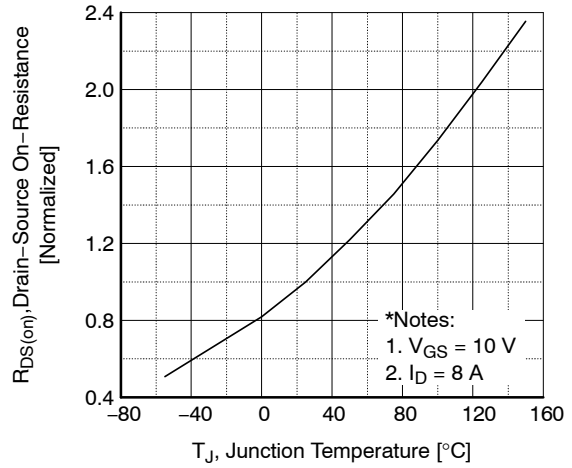
**Figure 6. Gate Charge Characteristics**

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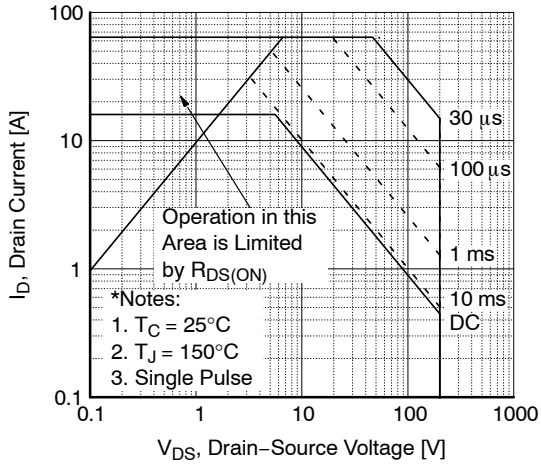
## TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



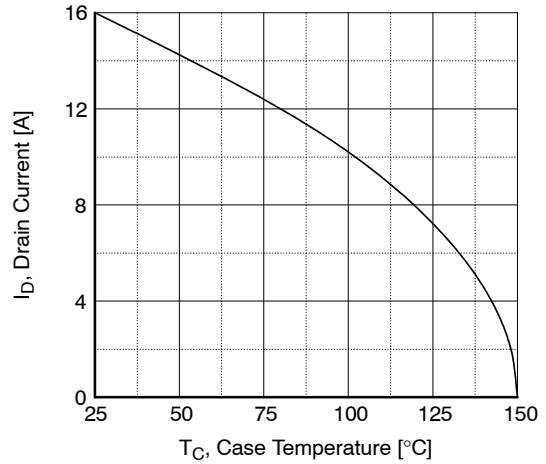
**Figure 7. Breakdown Voltage Variation vs. Temperature**



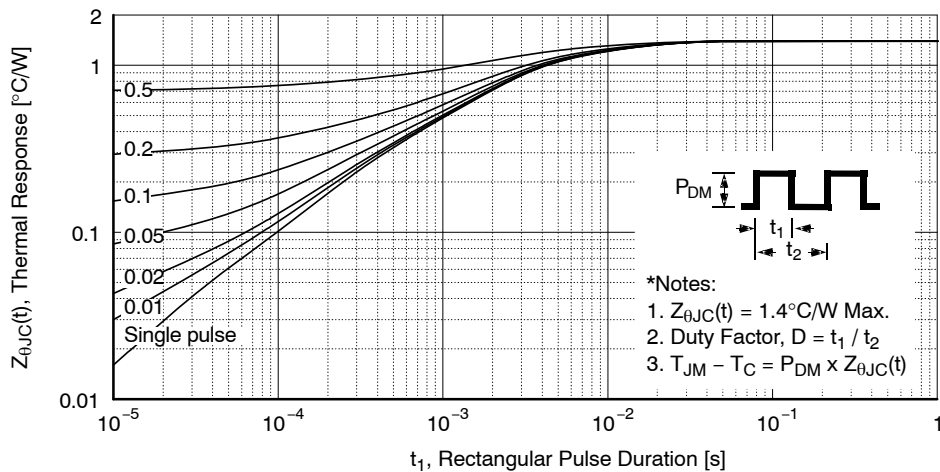
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**



**Figure 11. Transient Thermal Response Curve**

# FDD18N20LZ

## PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Reel Size	Tape Width	Shipping <sup>†</sup>
FDD18N20LZ	FDD18N20LZ	DPAK3 (TO-252 3 LD) (Pb-Free)	330 mm	16 mm	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS

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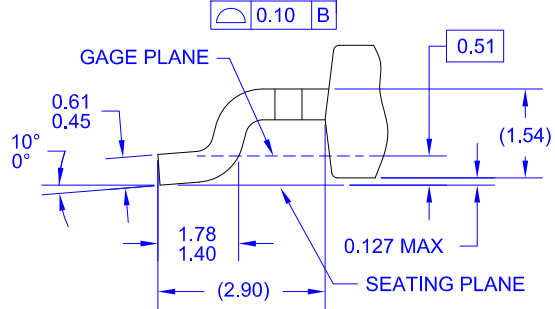
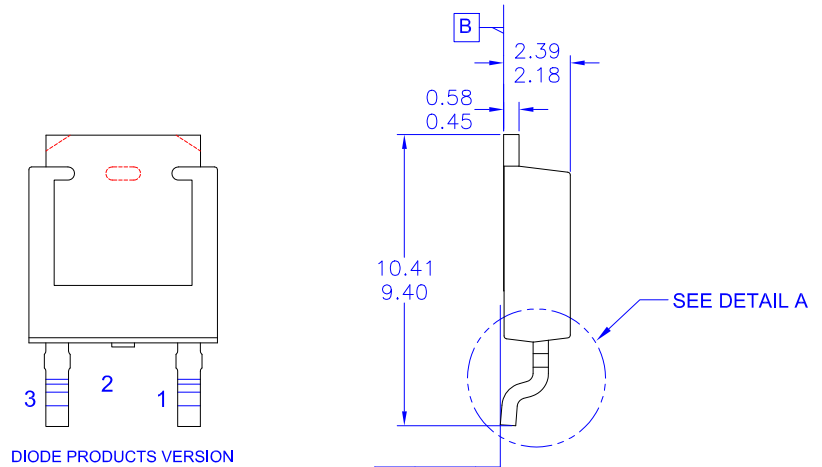
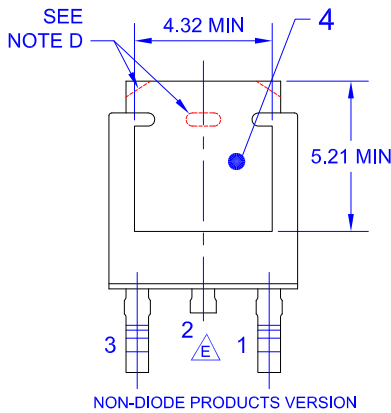
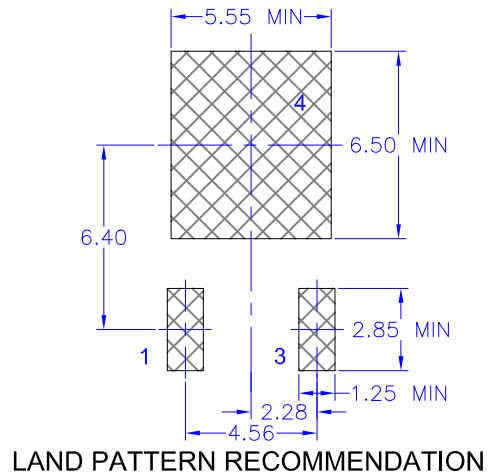
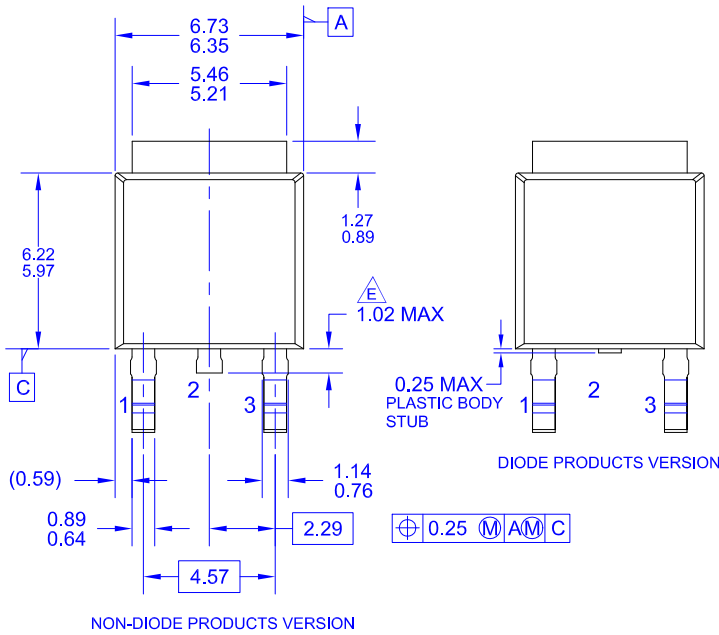


### DPAK3 (TO-252 3 LD)

#### CASE 369AS

#### ISSUE O

DATE 30 SEP 2016



- NOTES: UNLESS OTHERWISE SPECIFIED
- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.
  - B) ALL DIMENSIONS ARE IN MILLIMETERS.
  - C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
  - D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
  - E) TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS
  - F) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.
  - G) LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.

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